

- Johnson, C. K. (1976). ORTEPII. Report ORNL-5138. Oak Ridge National Laboratory, Tennessee, USA.
- Krasnikov, V. U., Constant, Z. A. & Bel'skii, V. A. (1985). *Izv. Akad. Nauk SSSR Neorg. Mater.* **21**, 1360–1363.
- Lukaszewicz, K. (1967). *Bull. Acad. Pol. Sci. Ser. Sci. Chim.* **15**, 47–51.
- Main, P., Fiske, S. J., Hull, S. E., Lessinger, L., Germain, G., Declercq, J.-P. & Woolfson, M. M. (1982). *MULTAN11/82. A System of Computer Programs for the Automatic Solution of Crystal Structures from X-ray Diffraction Data*. Universities of York, England, and Louvain, Belgium.
- Moigne, A., Boukhari, A. & Holt, E. M. (1991). *Acta Cryst.* **C47**, 2294–2297.
- Murashova, E. V., Velikodnyi, Yu. A. & Trunov, V. K. (1991). *Zh. Neorg. Khim.* **36**, 847–850.
- Riou, D. & Goreaud, M. (1990). *Acta Cryst.* **C46**, 1191–1193.
- Riou, D., Labbe, P. & Goreaud, M. (1988a). *C. R. Acad. Sci. Sér. C*, **307**, 1751–1756.
- Riou, D., Labbe, P. & Goreaud, M. (1988b). *C. R. Acad. Sci. Sér. C*, **307**, 903–907.
- Riou, D., Leligny, H., Pham, C., Labbe, P. & Raveau, B. (1991). *Acta Cryst.* **B47**, 608–617.
- Riou, D. & Raveau, B. (1991). *Acta Cryst.* **C47**, 1708–1709.
- Shannon, R. D. (1976). *Acta Cryst.* **A32**, 751–757.
- Spirlet, M. R., Rebizant, J. & Liegeois-Duyckaerts, M. (1993). *Acta Cryst.* **C49**, 209–211.
- Zachariasen, W. H. (1963). *Acta Cryst.* **16**, 1139–1144.

*Acta Cryst.* (1996). **C52**, 2963–2964

## Rubidium Indium Antimonide, $\text{Rb}_2\text{In}_2\text{Sb}_3$

OLIVIER GOURDON,<sup>a</sup> FLORENT BOUCHER,<sup>a</sup> JAMES GAREH,<sup>a</sup> MICHEL EVAIN,<sup>a</sup> CHARLES O'CONNOR<sup>b</sup> AND JUNG JIN-SEUNG<sup>b</sup>

<sup>a</sup>Laboratoire de Chimie des Solides, IMN, UMR CNRS 110, Université de Nantes, 2 Rue de la Houssinière, 44072 Nantes, France, and <sup>b</sup>Department of Chemistry, University of New Orleans, New Orleans, Louisiana 70148, USA. E-mail: evain@cnrs-imn.fr

(Received 28 May 1996; accepted 30 July 1996)

### Abstract

The structure of dirubidium diindium triantimonide, a layered material isotopic with  $A_2\text{In}_2\text{Sb}_3$  ( $A = \text{Na}, \text{K}, \text{Cs}$ ), is reported.

### Comment

The title compound,  $\text{Rb}_2\text{In}_2\text{Sb}_3$ , has been structurally characterized and shown to contain discrete layers of  $\text{InSb}_4$  tetrahedra separated by rubidium. These tetrahedra are connected via common corners, edges and short Sb–Sb distances. All distances and angles are as expected [In–Sb distances are in the range 2.8075 (10)–2.9646 (10) Å] and correspond well with the previously

reported isotopic structures [cf. In–Sb distances in the range 2.804 (4)–2.962 (4) Å for  $\text{Cs}_2\text{In}_2\text{Sb}_3$ ] (Cordier & Ochmann, 1991; Blase, Cordier, Poth & Weil, 1995).

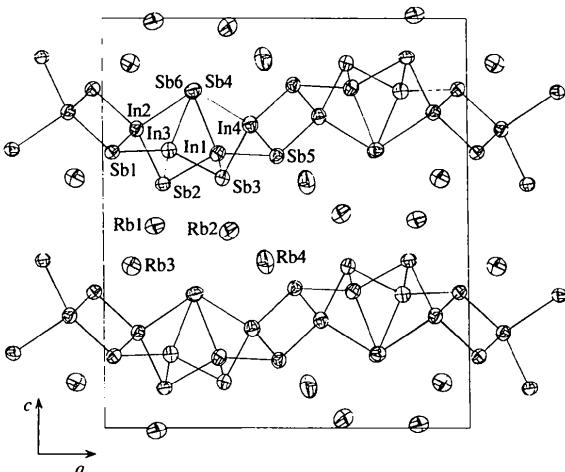


Fig. 1. ORTEP (Johnson, 1965) representation of the layered structure of  $\text{Rb}_2\text{In}_2\text{Sb}_3$  showing the  $\text{In}_2\text{Sb}_3$  layers separated by rubidium (90% probability level).

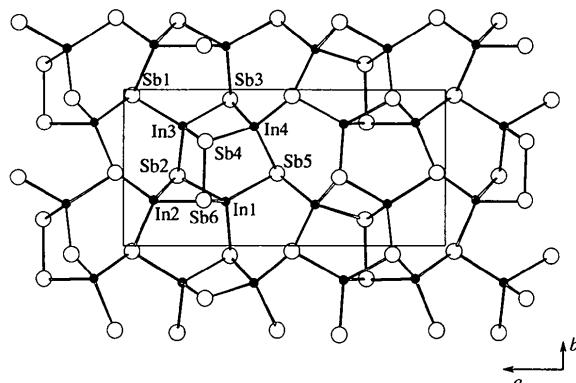


Fig. 2. Cross-section of the  $\text{In}_2\text{Sb}_3$  layer showing corner- and edge-sharing connections of  $\text{InSb}_4$  tetrahedra and the short Sb–Sb distances.

### Experimental

$\text{Rb}_2\text{In}_2\text{Sb}_3$  was prepared by direct combination of the elements. A dry quartz tube was charged with Rb (0.26 g, 3 mmol), In (0.23 g, 2 mmol) and Sb (0.36 g, 3 mmol). The tube was evacuated for 1.5 h at  $5 \times 10^{-3}$  Torr (1 Torr = 133.322 Pa) and sealed under vacuum. The sample was heated at 873 K in an automatic control furnace for 10 h and then cooled to ambient temperature over a 96 h period.

### Crystal data

$\text{Rb}_2\text{In}_2\text{Sb}_3$   
 $M_r = 765.83$

Ag  $K\alpha$  radiation  
 $\lambda = 0.56086$  Å

Monoclinic

 $P2_1/c$  $a = 15.555 (2) \text{ \AA}$  $b = 7.5692 (6) \text{ \AA}$  $c = 17.362 (7) \text{ \AA}$  $\beta = 90.598 (14)^\circ$  $V = 2044.0 (9) \text{ \AA}^3$  $Z = 8$  $D_x = 4.977 \text{ Mg m}^{-3}$  $D_m$  not measured

Cell parameters from 26 reflections  
 $\theta = 1.8\text{--}8.5^\circ$   
 $\mu = 11.538 \text{ mm}^{-1}$   
 $T = 293 (2) \text{ K}$   
 Rectangular block  
 $0.26 \times 0.18 \times 0.08 \text{ mm}$   
 Dark grey metallic

Data collection: Siemens *P4* diffractometer software. Cell refinement: *XSCANS* (Siemens, 1994). Data reduction: *XSCANS*. Program(s) used to refine structure: *SHELXTL/PC* (Sheldrick, 1995).

The work of JG was supported by the EC Human Capital Mobility program.

Lists of structure factors, anisotropic displacement parameters and complete geometry have been deposited with the IUCr (Reference: BR1152). Copies may be obtained through The Managing Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

**Data collection**Siemens *P4* four-circle diffractometerBisecting  $\omega$  scans

Absorption correction:

numeric

 $T_{\min} = 0.152$ ,  $T_{\max} = 0.409$ 

10 021 measured reflections

8167 independent reflections

**Refinement**Refinement on  $F^2$  $R(F) = 0.0388$  $wR(F^2) = 0.0732$  $S = 0.699$ 

8167 reflections

127 parameters

H-atom parameters not refined

 $w = 1/[\sigma^2(F_o^2) + (0.0093P)^2]$   
where  $P = (F_o^2 + 2F_c^2)/3$ 

$R_{\text{int}} = 0.0559$   
 $\theta_{\text{max}} = 26^\circ$   
 $h = -1 \rightarrow 24$   
 $k = -1 \rightarrow 11$   
 $l = -27 \rightarrow 27$   
 3 standard reflections monitored every 100 reflections  
 intensity decay: none

$(\Delta/\sigma)_{\text{max}} = 0.005$   
 $\Delta\rho_{\text{max}} = 1.679 \text{ e \AA}^{-3}$   
 $\Delta\rho_{\text{min}} = -1.625 \text{ e \AA}^{-3}$   
 Extinction correction: none  
 Atomic scattering factors from *International Tables for Crystallography* (1992, Vol. C, Tables 4.2.6.8 and 6.1.1.4)

Table 1. Fractional atomic coordinates and equivalent isotropic displacement parameters ( $\text{\AA}^2$ )

$$U_{\text{eq}} = (1/3) \sum_i \sum_j U_{ij} a_i^* a_j^* \mathbf{a}_i \cdot \mathbf{a}_j$$

	$x$	$y$	$z$	$U_{\text{eq}}$
Rb1	0.85862 (6)	0.02746 (14)	0.00788 (5)	0.0281 (2)
Rb2	0.34667 (6)	0.45606 (15)	0.97831 (6)	0.0298 (2)
Rb3	0.07657 (6)	0.4674 (2)	0.89068 (5)	0.0310 (2)
Rb4	0.55711 (6)	0.0548 (2)	0.09933 (6)	0.0367 (3)
In1	0.31611 (4)	0.72107 (9)	0.16956 (4)	0.01758 (2)
In2	0.90699 (4)	0.21146 (9)	0.27031 (4)	0.01658 (13)
In3	0.18136 (4)	0.23595 (9)	0.17727 (4)	0.01747 (14)
In4	0.40668 (4)	0.23851 (9)	0.24018 (4)	0.01798 (14)
Sb1	0.97431 (4)	0.53666 (9)	0.32768 (3)	0.01620 (12)
Sb2	0.16409 (4)	0.55444 (9)	0.09520 (3)	0.01652 (13)
Sb3	0.32931 (4)	1.06473 (8)	0.10988 (4)	0.01645 (13)
Sb4	0.25209 (4)	0.16508 (8)	0.82458 (4)	0.01753 (13)
Sb5	0.47704 (4)	0.53923 (9)	0.16277 (4)	0.01711 (13)
Sb6	0.24813 (4)	0.78693 (9)	0.82086 (4)	0.01772 (13)

Table 2. Selected geometric parameters ( $\text{\AA}$ ,  $^\circ$ )

In1—Sb3	2.8083 (10)	In3—Sb1 <sup>iii</sup>	2.8534 (9)
In1—Sb6 <sup>i</sup>	2.8425 (14)	In3—Sb4 <sup>v</sup>	2.8730 (13)
In1—Sb5	2.8602 (9)	In3—Sb3 <sup>ii</sup>	2.8983 (9)
In1—Sb2	2.9638 (10)	In4—Sb5	2.8663 (10)
In2—Sb1 <sup>ii</sup>	2.8494 (10)	In4—Sb3 <sup>ii</sup>	2.8704 (12)
In2—Sb1	2.8506 (10)	In4—Sb5 <sup>iii</sup>	2.8847 (10)
In2—Sb2 <sup>iii</sup>	2.8532 (12)	In4—Sb4 <sup>v</sup>	2.9215 (10)
In2—Sb6 <sup>v</sup>	2.8720 (10)	Sb4—Sb6 <sup>vii</sup>	2.8637 (9)
In3—Sb2	2.8118 (10)		

Symmetry codes: (i)  $x, \frac{3}{2} - y, z - \frac{1}{2}$ ; (ii)  $2 - x, y - \frac{1}{2}, \frac{1}{2} - z$ ; (iii)  $1 - x, y - \frac{1}{2}, \frac{1}{2} - z$ ; (iv)  $1 - x, 1 - y, 1 - z$ ; (v)  $x, \frac{1}{2} - y, z - \frac{1}{2}$ ; (vi)  $x, y - 1, z$ .

**References**

- Blase, W., Cordier, G., Poth, L. & Weil, K. G. (1995). *Z. Kristallogr.* **210**, 60.  
 Cordier, G. & Ochmann, H. (1991). *Z. Kristallogr.* **197**, 281–282; *ibid.* 283–284; *ibid.* 285–286.  
 Johnson, C. K. (1965). *ORTEP*. Report ORNL-3794. Oak Ridge National Laboratory, Tennessee, USA.  
 Siemens (1994). *XSCANS Users Manual*. Version 2.1. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.  
 Sheldrick, G. M. (1995). *SHELXTL/PC*. Version 5.04. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.

*Acta Cryst.* (1996). **C52**, 2964–2967

## Triclinic $\text{Fe}_3\text{Al}_2\text{Si}_3$ and Orthorhombic $\text{Fe}_3\text{Al}_2\text{Si}_4$ with New Structure Types

TAMARA IVANIVNA YANSON,<sup>a</sup> MYKOLA BOGDANOVYCH MANYAKO,<sup>a</sup> OKSANA IVANIVNA BODAK,<sup>a</sup> NESTOR VOLODYMYROVYCH GERMAN,<sup>a</sup> OLEG SAFONIEVYCH ZARECHNYUK,<sup>a</sup> RADOVAN ČERNÝ,<sup>b</sup> JÉSUS VICENTE PACHECO<sup>b</sup> AND KLAUS YVON<sup>b</sup>

<sup>a</sup>Department of Inorganic Chemistry, L'viv University, 6, Kyryla and Mefodiya Street, 290005 L'viv 5, Ukraine, and <sup>b</sup>Laboratoire de Cristallographie, Université de Genève, 24, quai Ernest-Ansermet, CH-1211 Geneva 4, Switzerland. E-mail: radovan.cerny@cryst.unige.ch

(Received 14 March 1996; accepted 1 July 1996)

**Abstract**

The title compounds, dialuminium triiron trisilicide and dialuminium triiron tetrasilicide, crystallize with new structure types. The coordination polyhedra in  $\text{Fe}_3\text{Al}_2\text{Si}_3$  derive from icosahedra and those in  $\text{Fe}_3\text{Al}_2\text{Si}_4$  from hexagonal cuboctahedra.

**Comment**

The ternary system Fe–Al–Si contains numerous ternary compounds. Six crystallize with known structures: